TOSHIBA Transistor Silicon NPN Epitaxial Type (PCT Process)

HN3C67FE

Audio Frequency Amplifier Applications AM Amplifier Applications

Small package (dual type)

High voltage and high current : V_{CEO} = 50V, I_C = 150mA (max)

High hFE : h_{FE} = 120~400

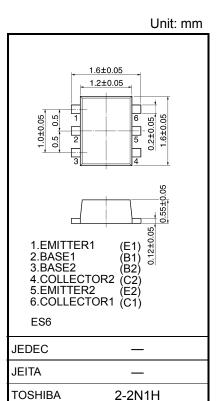
Excellent hFE linearity : $h_{FE} (I_C = 0.1 mA) / (I_C = 2 mA)$

= 0.95 (typ.)

Maximum Ratings (Ta = 25°C)

Characteristic	Symbol	Rating	Unit
Collector-base voltage	V_{CBO}	60	V
Collector-emitter voltage	V _{CEO}	50	V
Emitter-base voltage	V _{EBO}	5	V
Collector current	I _C	150	mA
Base current	Ι _Β	30	mA
Collector power dissipation	P _C *	100	mW
Junction temperature	Tj	150	°C
Storage temperature range	T _{stg}	-55~150	°C

^{*} Total rating

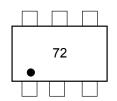


Weight: 0.003g (typ.)

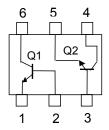
Electrical Characteristics (Ta = 25°C) (Q1, Q2 Common)

Characteristic	Symbol	Test Circuit	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current	I _{CBO}	_	V _{CB} = 60V, I _E = 0	_	_	0.1	μΑ
Emitter cut-off current	I _{EBO}	_	V _{EB} = 5V, I _C = 0	_	_	0.1	μA
DC current gain	h _{FE}	_	V_{CE} = 6V, I_C = 2mA	120	_	400	_
Collector-emitter saturation voltage	V _{CE (sat)}	_	I _C = 100mA, I _B =10mA	_	0.1	0.25	V
Transition frequency	f _T	_	V _{CE} = 10V, I _C = 1mA	60	_	_	MH_Z
Collector output capacitance	C _{ob}	_	V _{CB} = 10V, I _E = 0, f = 1MH _z	_	2	_	pF

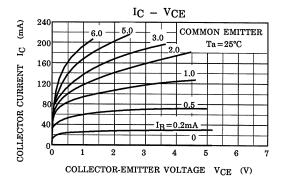
Marking

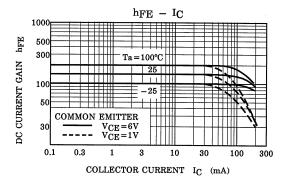


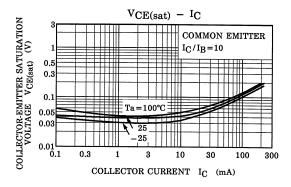
Equivalent Circuit (Top View)

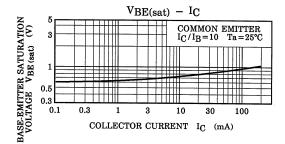


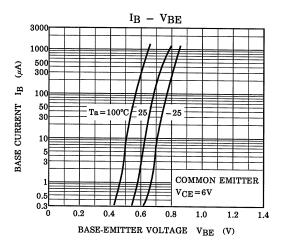
(Q1, Q2 Common)

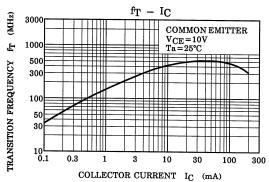


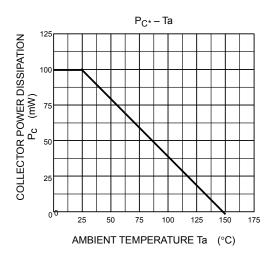












*Total Rating.

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